



Integrated Device Technology, Inc.
6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN # : A1412-02

PCN Type: Assembly Material

Data Sheet Change: None

Details Of Change: This notification is to inform our customers that IDT is converting to a new mold compound, Hitachi CEL-9750ZHF10AKL.

There is no change in the moisture sensitivity level (MSL).

You may contact your local sales representative to acknowledge this PCN and request samples.

Description	Changes	
	From	To
Mold Compound	Hitachi CEL-9750HF10F	Hitachi CEL-9750ZHF10AKL

Qualification Test Plan and Results:

Test Vehicle: TEPBGA-480 (2 lots) and PBGA-313 (1 lot)

Test Description	Test Method	Test Results (SS / Rej)		
		Lot 1	Lot 2	Lot 3
* Highly Accelerated Stress Test (Unbiased, 130°C/85% RH, 96Hrs)	JESD22-A118	30/0	30/0	30/0
* Temperature Cycle / Condition B (-55 °C to +125 °C, 700 Cyc)	JESD22-A104	30/0	30/0	30/0
High Temp. Storage Test (150 °C, 1000 Hrs)	JESD22-A103	30/0	30/0	30/0
Ball Shear Test	JESD22-B116	5/0	5/0	5/0
X-ray Examination	IDT Spec. MAC-3012 (Package voids, Die attach voids and Wire sweep)	45/0	45/0	45/0

Note:

* Test requires moisture pre-conditioning sequence per JESD22-A113 prior to stress test



Integrated Device Technology, Inc.
6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT II - PCN # : A1412-02

Affected Part Numbers

Part Number	Part Number	Part Number	Part Number
CA91C142D-25EE	CA91L750-100ILV	CA91L8260B-100IEV	TSI350A-66CLV
CA91C142D-33CE	CA91L8200B-100CE	CA91L862A-50IE	TSI384-133IL
CA91C142D-33CEV	CA91L8200B-100IE	CA91L862A-50IEV	TSI384-133ILV
CA91C142D-33IE	CA91L8260B-100CE	CA91L862A-50IL	
CA91C142D-33IEV	CA91L8260B-100CEV	CA91L862A-50ILV	